

Abstracts

The Calibration of a Universal Test Fixture

R.D. Pollard and R.Q. Lane. "The Calibration of a Universal Test Fixture." 1983 MTT-S International Microwave Symposium Digest 83.1 (1983 [MWSYM]): 498-500.

A broadband, universal transistor test fixture uses exchangeable inserts to accommodate most transistor types. The calibration of the fixture and its inserts by a reliable, accurate and easy to use scheme is described.

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